# **Power MOSFET** 30 V, 52 A, Single N–Channel, μ8FL

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- Low-Side DC-DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

www

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Param	eter		Symbol	Value	Unit
Drain-to-Source Voltage	n-to-Source Voltage			30	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	14.3	А
Current $R_{\theta JA}$ (Note 1)	)	T <sub>A</sub> = 85°C		10.3	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.21	W
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	20.3	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T <sub>A</sub> = 85°C		14.7	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.48	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	8.9	А
Current $R_{\theta JA}$ (Note 2)	_	T <sub>A</sub> = 85°C	1	6.4	
Rower Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	P <sub>D</sub>	0.85	W
Continuous Drain		$T_C = 25^{\circ}C$	۱ <sub>D</sub>	52	А
Current $R_{\theta JC}$ (Note 1)		$T_{C} = 85^{\circ}C$	1	38	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	29.8	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	170	А
Current Limited by Pkg.	T <sub>A</sub> :	= 25°C	I <sub>DmaxPkg</sub>	70	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to +150	°C
Source Current (Body Diode)			۱ <sub>S</sub>	35	А
Drain to Source DV/DT			dV/dt	6.0	V/ns
$      Single Pulse Drain-to-Source Avalanche Energy \\ (T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, \\ I_L = 31 \text{ A}_{pk}, L = 0.1 \text{ mH}, \text{ R}_G = 25 \Omega )      $			E <sub>AS</sub>	48	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

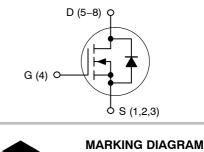


# **ON Semiconductor®**

### http://onsemi.com

V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX		I <sub>D</sub> MAX
30 V	5.5 m $\Omega$ @ 10 V	52 A
30 V	8.0 mΩ @ 4.5 V	52 A

### N-Channel MOSFET



1 WDFN8 (μ8FL) CASE 511AB

4939 A

Y

s c s c s c G c	O 4939 AYWW• •					
= Specific Device Code = Assembly Location						

WW = Work Week = Pb-Free Package

= Year

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTTFS4939NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4939NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	4.2	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	56.5	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	146.5	
Junction-to-Ambient – (t $\leq$ 10 s) (Note 3)	$R_{\thetaJA}$	28	

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size (40 mm<sup>2</sup>, 1 oz. Cu).

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

	Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit
0	FF CHARACTERISTICS					-		•
Di	rain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		30			V
	rain-to-Source Breakdown Voltage emperature Coefficient	$V_{(BR)DSS}/T_J$				15		mV/°C
Ze	ero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C			1.0 10	μΑ
G	ate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>				±100	nA
L	N CHARACTERISTICS (Note 5)	GSS	•DS = 0 •, •GS	- ±20 V			100	ПА
	ate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =	= 250 uA	1.2		2.2	V
Ne	egative Threshold Temperature oefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Dı	rain-to-Source On Resistance	$V_{GS} = 10 V$	I <sub>D</sub> = 20 A I <sub>D</sub> = 10 A		4.1 4.1	5.5	mΩ	
				$I_{\rm D} = 20 \rm{A}$		6.0	8.0	
			V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 10 A		5.9		
Fo	orward Transconductance	<b>g</b> Fs	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A		35		S	
Cł	HARGES AND CAPACITANCES							
In	put Capacitance	C <sub>iss</sub>				1979		pF
	utput Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MH	łz, V <sub>DS</sub> = 15 V		711		
al <del>aSI</del> Re	neet40.com everse Transfer Capacitance	C <sub>rss</sub>				20.2		
Тс	otal Gate Charge	Q <sub>G(TOT)</sub>				12.4		nC
٦ŀ	hreshold Gate Charge	Q <sub>G(TH)</sub>				3.2		
G	ate-to-Source Charge	$Q_{GS}$	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 1	5 V, I <sub>D</sub> = 20 A		6.0		
G	ate-to-Drain Charge	Q <sub>GD</sub>				1.8		
Тс	otal Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 20 A			28		nC
SWITCHING CHARACTERISTICS (N		te 6)						
Τι	urn-On Delay Time	t <sub>d(on)</sub>				12.2		ns
Ri	ise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	<sub>S</sub> = 15 V,		20.6		1
Τι	urn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub> I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		20.8		1
F٤	all Time	t <sub>f</sub>	F			3.9		7

5. Pulse Test: pulse width = 300  $\mu$ s, duty cycle  $\leq$  2%.

6. Switching characteristics are independent of operating junction temperatures.

1.1

2.0

Ω

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	<b>S</b> (Note 6)						
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,			8.7		ns
Rise Time	t <sub>r</sub>				19.5		1
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 15 A, R <sub>G</sub> =	3.0 Ω		25.3		1
Fall Time	t <sub>f</sub>				3.2		1
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$v_{\rm GS} = 0 v$ ,	$T_J = 25^{\circ}C$		0.84	1.2	V
			$T_J = 125^{\circ}C$		0.71		1
Reverse Recovery Time	t <sub>RR</sub>				35.5		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 V, d_{IS}/d_t =$	100 A/μs,		19		1
Discharge Time	t <sub>b</sub>	$V_{GS} = 0 V$ , $d_{IS}/d_t = I_S = 20 A$			16.5		1
Reverse Recovery Charge	Q <sub>RR</sub>				28		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.38		nH
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.054		1
Gate Inductance	L <sub>G</sub>				1.3		1
		1					

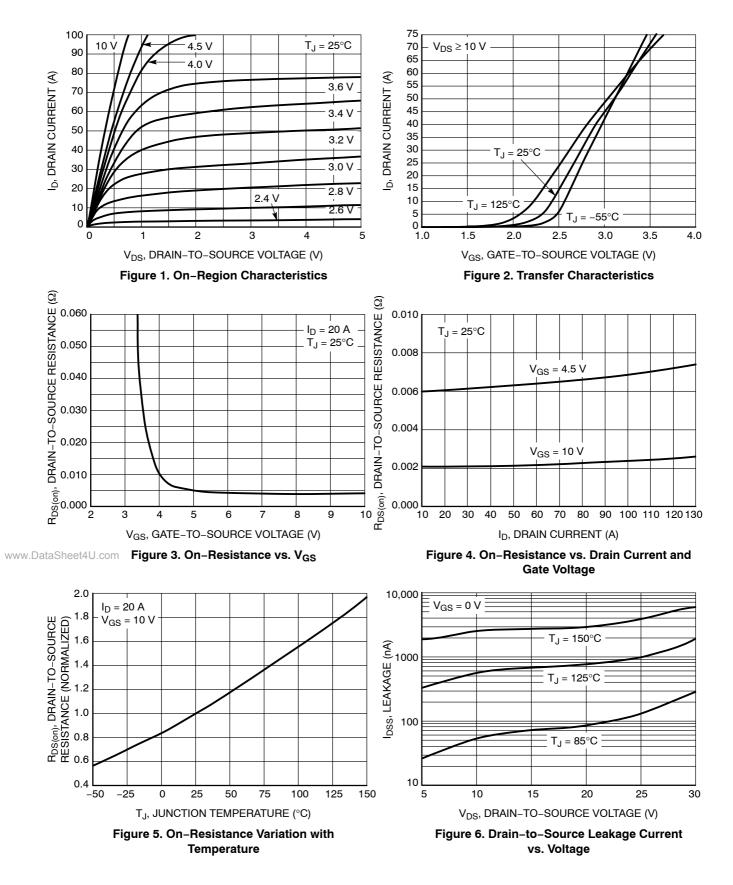
 $\begin{array}{ll} \text{5. Pulse Test: pulse width = 300 } \mu\text{s, duty cycle } \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

 $R_{G}$ 

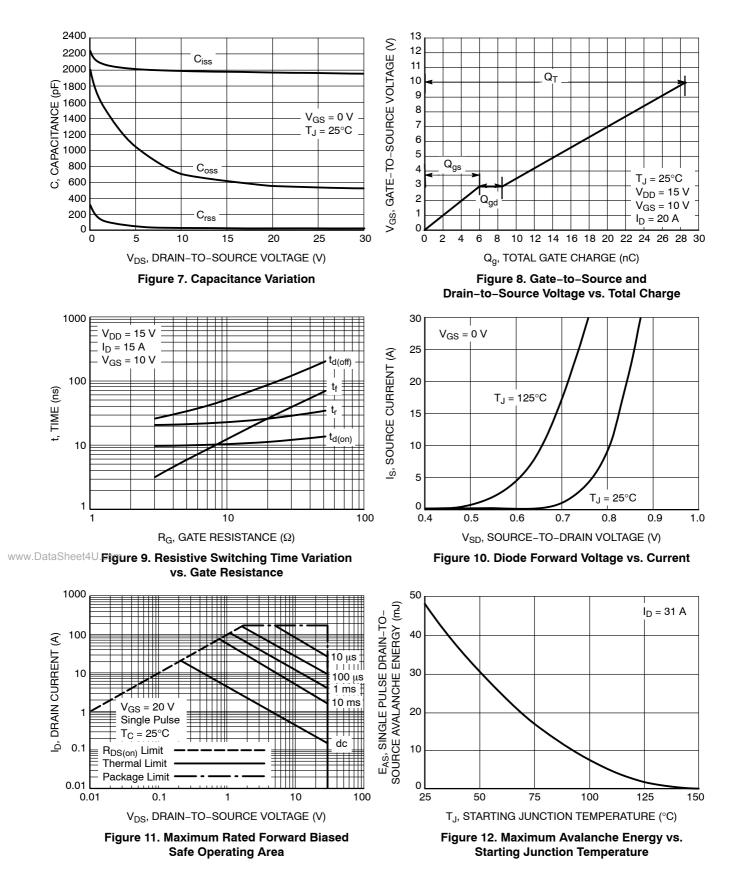
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Gate Resistance

### **TYPICAL CHARACTERISTICS**



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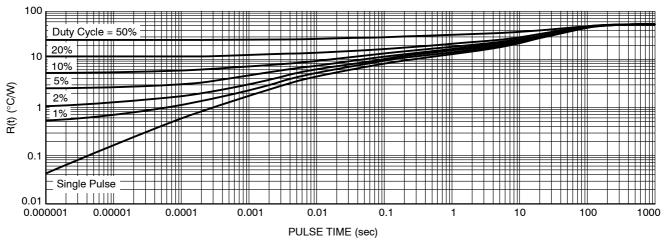
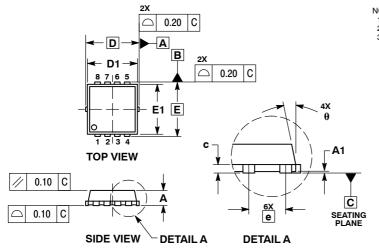


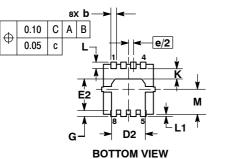
Figure 13. Thermal Response

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#### PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB-01 ISSUE B





NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

PROTRUSIONS OR GATE BURRS.								
	м	LLIMETE	RS	INCHES				
DI	MIN	NOM	MAX	MIN	NOM	MAX		
Α	0.70	0.75	0.80	0.028	0.030	0.031		
A1	0.00		0.05	0.000		0.002		
b	0.23	0.30	0.40	0.009	0.012	0.016		
С	0.15	0.20	0.25	0.006	0.008	0.010		
D		3.30 BSC		0.130 BSC				
D1	2.95	3.05	3.15	0.116	0.120	0.124		
D2	1.98	2.11	2.24	0.078	0.083	0.088		
E		3.30 BSC		0.130 BSC				
E1	2.95	3.05	3.15	0.116	0.120	0.124		
E2	1.47	1.60	1.73	0.058	0.063	0.068		
е		0.65 BSC			0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020		
K	0.64			0.025				
L	0.30	0.43	0.56	0.012	0.017	0.022		
L1	0.06	0.13	0.20	0.002	0.005	0.008		

1.60

0.055

0.059

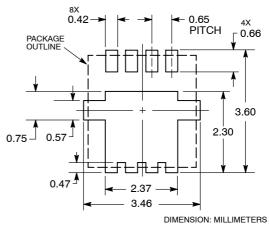
0.063 12 °

#### **SOLDERING FOOTPRINT\***

1.50

М

1.40



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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